


<b>Issue Classification</b> 	<b>Application/Control No.</b>		<b>Applicant(s)/Patent under Reexamination</b>	
	10/530,285		BETEILLE, FABIEN	
	<b>Examiner</b>		<b>Art Unit</b>	
	Binh X. Tran		1792	

ISSUE CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)						
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
216		33			216	59	65				
INTERNATIONAL CLASSIFICATION											
C	0	3	C	15/00							
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				/							
(Assistant Examiner) (Date)					/Binh X Tran/ 12/31/2008					Total Claims Allowed: 12	
(Legal Instruments Examiner) (Date)										O.G. Print Claim(s) 1	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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